Substrate-mediated hyperbolic phonon polaritons in MoO₃

Abstract: Hyperbolic phonon polaritons (HPhPs) are hybrid excitations of light and coherent lattice vibrations that exist in strongly optically anisotropic media, including two-dimensional materials (e.g., MoO₃). These polaritons propagate through the material’s volume with long lifetimes, enabling novel mid-infrared nanophotonic applications by compressing light to sub-diffractional dimensions. Here, the dispersion relations and HPhP lifetimes (up to ≈12 ps) in single-crystalline α-MoO₃ are determined by Fourier analysis of real-space, nanoscale-resolution polariton images obtained with the photothermal induced resonance (PTIR) technique. Measurements of MoO₃ crystals deposited on periodic gratings show longer HPhPs propagation lengths and lifetimes (≈2×), and lower optical compressions, in suspended regions compared with regions in direct contact with the substrate. Additionally, PTIR data reveal MoO₃ subsurface defects, which have a negligible effect on HPhP propagation, as well as polymeric contaminants localized under parts of the MoO₃ crystals, which are derived from sample preparation. This work highlights the ability to engineer substrate-defined nanophotonic structures from layered anisotropic materials.

Keywords: 2D materials; hyperbolic materials; phonon polaritons; photothermal induced resonance; sub-wavelength optical confinement.

1 Introduction

The ability to confine and to guide light at length scales smaller than its free-space wavelength (λ₀) enables numerous nanophotonic applications, including surface-enhanced absorption and scattering [1–5], nanoscale waveguides [6–8], and non-linear optics [9, 10]. Polaritons, hybrid excitations of light and coherent charge oscillations in materials, offer a means to achieve such optical control at the nanoscale. For example, several spectroscopic techniques utilize surface plasmon polaritons (SPPs) in metals to boost their sensitivities [2, 11, 12]. However, the fast carrier scattering times in metals (≈fs) results in high losses that generally hinder many nanophotonic applications, especially in the mid-infrared (mid-IR) [13, 14].

Phonon polaritons (PhPs), by contrast, couple light with optical phonons in a polar crystal. These excitations can exist only within spectral ranges, known as reststrahlen bands, delimited by transverse optical (TO) and longitudinal optical (LO) phonon pairs [14, 15]. Within these bands, at least one component of the material’s electric permittivity tensor is negative, resulting in high optical reflectivity while supporting surface-bound PhP modes. Strongly anisotropic materials, in which the real permittivity differs in sign along orthogonal principal axes, support hyperbolic PhPs (HPhPs) within the material’s volume, propagating at angles determined by the wavelength-dependent permittivity [14, 16, 17]. Such hyperbolic materials, therefore, enable high optical
confinements (~1% \( \lambda_0 \)) in the mid-IR, with longer lifetimes (~ps) and lower losses compared with SPPs [14, 17–19]. Additionally, HPhPs provide the potential for negative refraction, superlensing, and other effects [16, 20, 21].

A number of natural hyperbolic materials supporting HPhPs have been discovered, including h-BN [22, 23] and MoO3 [24–26], which have been the subject of recent reviews [27, 28]. Among these materials, MoO3 is of particular interest due to its natural in-plane anisotropic dispersion [25]. To date, the optical dispersion relations in these materials have been predominantly determined by using scattering-type scanning near-field optical microscopy (s-SNOM) thanks to its ability to image HPhP propagation in real space with nanoscale resolution [20, 24, 29, 30]. Recently, similar investigations were accomplished with photoinduced force microscopy (PiFM) [26, 31, 32] and photothermal induced resonance (PTIR) [32–34], two nanoscale-capable IR techniques that do not require a spectrally sensitive detector in the far-field. In particular, PTIR was shown to detect a more complete set of theory-predicted HPhP modes in h-BN frustum structures [35, 36], revealing excitations not observed by s-SNOM. With PTIR, light absorption in a sample is measured by transducing the photo-induced thermal expansion of the sample directly beneath the probe tip of an atomic force microscope [37]. Notably, PTIR can sense sample composition far below the exposed surface [38–40], at depths exceeding 1 \( \mu \)m [33, 41], with its signal proportional to the local sample absorption coefficient [42], enabling easy comparison of PTIR spectra with far-field IR databases [40, 42, 43]. These characteristics enable broad applications in materials science [44–46] and biology [47–51]. In nanophotonics, PTIR has been used to characterize integrated waveguides [52], plasmonic modes [53, 54], and near-field absorption enhancement of plasmonic nanostructures [55–57]. Here, we leverage PTIR to visualize HPhPs propagating in MoO3 single-crystalline thin layers exfoliated on gold-coated glass or on SiO2/Si substrates patterned into one-dimensional (1D) gratings. Fourier analyses of PTIR absorption maps and real-space parameterized models of HPhP propagation were used to determine the dispersion relations and to quantify lifetimes, propagation lengths, and optical compressions of HPhPs in MoO3 single crystals. Increased HPhP propagation lengths and lifetimes of about 2x were observed in suspended regions of MoO3 flakes compared with those in direct contact with SiO2. In addition to demonstrating similar capabilities to s-SNOM, here we highlight the ability of PTIR to detect and to discern intrinsic (within MoO3) and extrinsic (contaminants) subsurface defects. Understanding and controlling the factors that influence HPhP propagation, as examined here, enhances the ability to engineer light–matter interactions at dimensions below the diffraction limit, which is critical for a variety of materials and nanophotonic applications.

2 Results and discussion

The structure of orthorhombic \( \alpha \)-MoO3 (Figure 1a) consists of stacked bilayers composed of distorted MoO6 octahedra with three crystallographically inequivalent oxygen atoms [58]. Thanks to its layered, van der Waals type structure, single crystals of \( \alpha \)-MoO3 can be exfoliated into flakes of various thicknesses and sizes, with edges predominantly aligned with crystallographically defined [100] and [001] directions. Additionally, MoO3 is characterized by numerous IR-active optical phonon modes, resulting in multiple reststrahlen bands that can support HPhP propagation [59]. Two of these bands, between about 820 and 972 cm\(^{-1}\) ("lower band"), and between about 958 and 1004 cm\(^{-1}\) ("upper band") [24–26, 59], were probed in this work (for further reststrahlen band details see discussion S1 in Supplementary material).

The excitation of HPhPs typically requires the use of evanescent illumination geometries or light-scattering sites to bridge the momentum mismatch between incident photons in free space and polaritons within a material [14, 30]. Intrinsic features, such as crystal edges, or extrinsic ones, such as plasmonic nanostructures or the tip of a scanning probe microscope, commonly fulfill this role [30, 36]. For materials confined in at least one dimension, as in the case of the thin flakes studied here, HPhPs are permitted only with specific (quantized) momenta [35, 60], meaning that they propagate only at selected angles determined by the permittivity tensor of the material. Consequently, in s-SNOM and PTIR real-space maps, HPhPs appear as periodic fringes with spacing proportional to the flake thickness (Figure S1). The polariton fringes observed in PTIR measurements result from especially intense local heating and thermal expansion of the sample that occurs in regions where the strong tip-enhanced near-field overlaps with the polariton field [36].

Polaritons launched at crystal edges ("edge-launched") propagate through the material with characteristic wave-numbers and are detected at the probe with corresponding spatial frequencies determined by the material dispersion. Similarly, light scattered by the probe tip generates "tip-launched" polaritons that emanate outward and are detected after reflecting back to the probe from another interface such as a flake edge. Both edge-launched and tip-
launched HPhPs can exist and be detected simultaneously in PTIR absorption maps, which capture a superposition of all excited modes. However, tip-launched polaritons are characterized by fringe periods that are approximately half that of edge-launched modes of the same order (see below) [61]. Depending on the relative excitation efficiencies of a particular sample, either tip- or edge-launched (or both) HPhPs may be prominently generated and observed. Nevertheless, tip- and edge-launched HPhPs are fundamentally the same phenomenon and their approximate 2:1 wavenumber ratio is just a consequence of the scanning probe measurement scheme (see below).

Representative PTIR absorption maps measured in two MoO$_3$ reststrahlen bands (Figure 1) reveal significant differences in HPhP propagation. In the lower band (Figure 1c), absorption fringes are aligned parallel to the left and right edges of the MoO$_3$ flake (nearly vertical) but no fringes are observed along the top (horizontal) edge of the flake. By contrast, in the upper reststrahlen band (Figure 1d), fringes parallel to all visible flake edges are observed, though with lower spatial frequencies than in the lower band. Additionally, in this case, interference between cross-propagating polaritons is evident, especially near the corners of the flake (e.g., Figure 1d, top-right). Such differences reflect the optical anisotropy of MoO$_3$ and the distinct hyperbolic characters of the two reststrahlen bands (upper band, type I; lower band type II), as observed previously in s-SNOM studies on SiO$_2$ substrates [24–26]. Therefore, PTIR images of HPhP propagation along flake edges can be used to identify the crystallographic orientation of the MoO$_3$ flake, which is indicated in Figure 1.

Real-space PTIR absorption maps encode information related to the superposition of all HPhP modes propagating in the hyperbolic material as variations (e.g., fringes) in the PTIR signal intensity. Discrete Fourier transforms (DFTs) of these real-space maps separate, in frequency space, the polaritons (peaks in the computed power spectra; see, e.g., Figure 2c) from the background absorption and other artifacts. Polaritons observed in this manner can be attributed either to edge- or tip-launched HPhPs propagating in the hyperbolic media, which we model here as damped harmonic oscillations.

For HPhPs propagating in one dimension along an $x$-coordinate axis, with angular wavenumber $k$ and experiencing damping $\gamma$, we fit Equation (1) to the measured real-space absorption profiles.

\[
\text{Absorption} \propto \sum_i A_i e^{-\gamma x} \cos(\frac{k_i x + \varphi_i})
\]

(1)

In this model, a phase parameter ($\varphi$) accounts for offsets in the relative positions of the measurement origin (taken to
be the topographically identified flake edge) and the fringe pattern, while $A$ scales the model amplitude to match the measured intensities. Since, in general, PTIR absorption profiles represent superpositions of HPhPs, the model sums over $i$ independent modes, which are identified by peaks ($k$) in their power spectra (see below and Figure 2c). By fitting this model to the PTIR absorption profiles we obtain estimates of the parameters ($A_i$, $\gamma_i$, $k_i$, $\varphi_i$) that characterize each mode. These parameters can be used to quantify the HPhP damping rates and lifetimes. This analysis is illustrated in Figure 2 for a MoO$_3$ flake with its edge aligned nearly perpendicular (vertical) to the fast-scan direction of the probe (horizontal). In this configuration, sequentially measured scan lines possess an approximate translational symmetry along the slow-scan direction of the probe (vertical). Consequently, column-wise (vertical) averaging of pixels in the resulting PTIR images enables 1D analyses with enhanced signal-to-noise ratios. The DFT power spectrum (Figure 2c) of the averaged, 1D absorption profile reveals a prominent polariton peak ($\approx 16.7 \, \text{µm}^{-1}$). By plotting the angular wavenumbers of the detected DFT peaks (blue circles in Figure 2d) obtained from the Fourier analysis of a series of PTIR images, measured at different IR wavelengths, we constructed the HPhP dispersion curve of this MoO$_3$ crystal. Clearly, the measured polariton dispersion does not match the trend line predicted by theory for the first ($n=1$) or second ($n=2$) order edge-launched HPhP modes (dashed lines in Figure 2d); see theory details in Supplementary material S1.2. However, the measured angular wavenumbers are approximately double the values predicted for the first order edge-launched mode. Therefore, we attribute the prominent peaks in the DFT plots to HPhPs launched by the gold-coated probe tip [61]. For tip-launched HPhPs, movement of the probe toward or away from a flake edge changes the distance traversed by tip-launched HPhPs by twice that of the corresponding edge-launched HPhPs (see Equation (1)), leading to an apparent doubling of the spatial frequencies of HPhPs launched by the tip [61]. Scaling the
observed spatial frequencies by a factor of 1/2 enables reconstruction of the complementary edge-launched HPhP dispersion curve (red circles in Figure 2d), which coincides closely with theoretical predictions for edge-launched polaritons. The relative amplitudes of the tip- and edge-launched peaks in the DFT power spectra depend on the relative launching efficiencies and can vary between samples and scattering sites [30]. Typically, tip-launched HPhPs are assumed to originate from an azimuthally symmetric source (probe tip), and propagate outward with a circular wave front that decays in intensity proportional to an additional \( \sqrt{x} \) prefactor not shown in Equation (1) but accounted for in our fitting and subsequent analyses. For the remainder of this work, HPhP propagation characteristics are reported for the cases of edge-launched HPhPs, either observed directly or from scaled analyses of more prominently detected tip-launched HPhPs.

Additional HPhP characteristics can be derived from the model-fit parameters. Significantly, the damping factors describe the rates at which HPhPs decay in the material and can be related to their propagation lengths (\( L \)), as shown in Figure S3, using Equation (2).

\[
L = \frac{1}{\gamma}
\]

Additionally, the speed (group velocity, \( v_g \)) of HPhP propagation through the material can be determined from the slope of the dispersion curve,

\[
v_g = \frac{\partial \omega}{\partial k}
\]

which is shown in Figure 2e for HPhPs in the lower reststrahlen band. We note that HPhPs in MoO\(_3\) [25], and other hyperbolic materials [14, 19], propagate with high optical compressions (\( \approx 30 \times, \lambda_{\text{HPhP}} \approx 3 \% \lambda_0 \)) and at speeds much slower than the corresponding free-space photons; here, \( v_g = 0.1\% \ c \), among the slowest reported values for such materials [25, 62]. Furthermore, HPhP lifetimes (\( \tau \)) can be estimated from the approximate relationship between the propagation length and group velocity shown in Equation (4).

\[
\tau = \frac{L}{v_g}
\]

These characteristics enable quantitative comparisons of HPhP propagation in different materials and samples, thus permitting a comparison of their effectiveness in various nanophotonic applications. To this end, HPhPs in the lower MoO\(_3\) reststrahlen band were found to have lifetimes up to about 9 ps (Figure 2f), which are about two orders of magnitude longer than SPP in Au at near-visible wavelengths [63, 64]. The lifetimes measured here, for HPhPs propagating in MoO\(_3\) on a gold-coated substrate, are longer than the lifetimes reported previously on SiO\(_2\) surfaces (\( \approx 1.9 \) ps) [25]. This difference, in large part, is due to the long propagation lengths of the HPhPs (determined to be tip-launched) measured in these crystals.

Despite traveling within the volume of a host material, HPhPs are also sensitive to the surrounding media through their evanescently decaying external fields. These evanescent fields limit the range of HPhP interactions outside of the hyperbolic material, typically to a few tens of nm, similar to the decay range of SPPs [65, 66]. Consequently, variations in the local complex refractive index, such as near material discontinuities, can modify the dispersion, damping, and optical compression of HPhPs [67–71]. Measurements of a MoO\(_3\) crystal deposited onto a linearly patterned SiO\(_2\) substrate grating (alternating SiO\(_2\) lines and 95-nm-deep trenches of nearly equal widths; see Figure 3c and Section 4 for details) enabled side-by-side examination of tip-launched HPhPs propagating in both substrate-supported and suspended regions, revealing clear differences (Figure 3b and d). In suspended regions, HPhP fringes extend farther from the crystal edges and have lower optical compressions than HPhPs propagating in regions of the MoO\(_3\) crystal in direct contact with the SiO\(_2\) substrate. Quantitative comparison of PTIR absorption profiles measured at 910 cm\(^{-1}\), averaged along narrow bands centered within each region, reveals that HPhPs in suspended regions propagate with wavelengths \( \approx 1.5 \times \) longer than in regions in direct contact with the substrate (Figure 3f). Extension of this analysis to other excitation wavelengths yields the dispersion relations and propagation parameters characterizing HPhPs in each of these regions (Figure S4), including lifetimes of up to \( \approx 12 \) ps in suspended regions of the MoO\(_3\) crystal (Figure 3b). We hypothesize that the shortened lifetimes for HPhPs propagating in the supported regions (\( \approx 5 \) ps) are a result of dissipative interactions with the SiO\(_2\) substrate, which is characterized by a broad and strong (i.e., large imaginary refractive index) phonon resonance near 1075 cm\(^{-1}\). These interactions are not experienced as strongly within suspended MoO\(_3\) regions. Unlike the sharp, step-like changes in the grating topography, the HPhP fringes in the PTIR absorption maps exhibit gradual transitions from a compact, high spatial frequency arrangements in the SiO\(_2\)-contacted regions of the flake, to more diffuse, low spatial frequency arrangements in suspended regions. The extent over which these transitions occur illustrates the lateral range of the gradually weakening influence of the supporting substrate on HPhPs propagation, which is proportional to the polaritonic wavelength. As expected, these transitions become sharper for HPhPs with higher optical
These results demonstrate that substrate engineering is a viable strategy for controlling HPhP propagation with direct, localized effects on HPhP lifetimes and optical compressions, in agreement with previous studies [69, 70]. Since we detect no significant deformations of the MoO₃ crystal due to uneven surface contact or mechanical loading by the probe tip in the suspended regions, we expect lattice strain to play a negligible role in the variations in HPhP propagation observed here.

The PTIR measurements presented here also reveal crystal defects and buried contaminants that are imperceptible to examinations of only the exposed sample topography or that would be difficult to detect with primarily surface-sensitive methods. Unlike s-SNOM, for which the sensitivity of the tip-scattered light decreases...
rapidly as a function of the depth [33, 72], PTIR is capable of detecting subsurface features at depths up to a few µm, comparable with the IR light penetration depth [33, 34, 73]. Figure 4 shows PTIR absorption maps at 985 and 910 cm\(^{-1}\) of the same MoO\(_3\) flake seen in Figure 3 (different location), revealing relatively strong absorption in regions localized over trenches in the substrate. Absorption spectra measured on these features exhibit a distinctive peak at \(\approx 1264\) cm\(^{-1}\) that we attribute to the Si–CH\(_3\) asymmetric deformation of polydimethylsiloxane (PDMS) residue [40]. Since no significant topographic features were observed on the exposed surface, we conclude that these features represent PDMS contaminants trapped primarily in the trenches beneath the crystal, derived from the polymer stamp used to prepare the sample (see Section 4). We observe HPhPs propagating in the MoO\(_3\) crystal directly above the PDMS contaminants (Figure 4b). However, due to the PDMS background absorption, the effect of PDMS on HHP propagation could not be quantified properly here. In addition to extrinsic contamination, seemingly intrinsic defects present in some MoO\(_3\) crystals were also observed in PTIR absorption maps that do not correspond to obvious topographic features and with apparent negligible affect HHP propagation (see Figure 1 and Supplementary materials Section S6.1).

3 Conclusions

In summary, PTIR absorption maps visualize HPhPs propagating in exfoliated \(\alpha\)-MoO\(_3\) single crystals. By combining real-space PTIR images and Fourier analyses, we determined the polariton dispersion relations, propagation lengths, lifetimes, and group velocities in MoO\(_3\) crystals. Long HHP lifetimes, in excess of 10 ps, were measured for HPhPs propagating in MoO\(_3\) with optical compressions \(>30\times\). The effects of substrate morphology were tested by comparing HPhP propagation in regions of a MoO\(_3\) flake, deposited on a grating substrate, that were either suspended or in direct contact with SiO\(_2\). Polaritons in suspended regions of the flake were found to propagate farther, with longer lifetimes (\(>2\times\)) and lower optical compressions (\(>1.5\times\)), than those in regions in direct contact with the substrate. Additionally, by leveraging the ability of PTIR to sense subsurface features, we detected and identified the composition of contaminants (PDMS) beneath regions of a MoO\(_3\) flake, which originated from the sample preparation procedure. We also observed that some intrinsic crystal defects in MoO\(_3\) had negligible impacts on HHP propagation. This work demonstrates the versatility of PTIR for nanophotonic measurements of HPhPs, which provides a useful complement to s-SNOM studies. Furthermore, leveraging substrate morphology and material composition, as demonstrated here, represents a viable technique that enhances the ability to engineer and to control HPhP propagation in other nanophotonic systems.

4 Methods

4.1 Synthesis of single-crystalline \(\alpha\)-MoO\(_3\)

Single-crystalline flakes of \(\alpha\)-MoO\(_3\) were grown by the physical vapor transport method. At one end of an evacuated quartz ampoule, MoO\(_3\) polycrystalline powder (99.9999%) was heated to a temperature of \(\approx 830\) °C, which is slightly higher than its melting point (\(\approx 795\) °C), for
2 h. Single-crystalline MoO₃ flakes formed at the cooler end of the ampoule, which was maintained at a temperature of ≈700 °C.

4.2 Exfoliation and deposition of MoO₃

Flakes of MoO₃ were exfoliated as single crystals directly onto uniform, gold-coated (~100 nm) glass substrates by using standard techniques [74]. Alternatively, for surface morphology experiments, exfoliation of MoO₃ was carried out onto PDMS stamps, which were then used to transfer the crystals onto SiO₂/Si gratings. The gratings were characterized by 1D lines of SiO₂ (width =1.4 μm, pitch =3 μm) separated by trenches (depth =95 nm), on an n-doped (conductivity =4.5 Ω cm) Si substrate with native oxide (~1 nm), as depicted schematically in Figure 3c. Stamps, carrying exfoliated MoO₃ flakes, were aligned and brought into contact with the grating surface and held while heated to temperatures of ≈40 °C. Slowly separating the stamp from the substrate resulted in the MoO₃ being transferred from the PDMS to grating surface. Due to the reduced contact area between a flake and the grating substrate, deposition from the stamp to the grating typically was more challenging than deposition onto a flat surface. Consequently, repeated iterations of the deposition procedure (contact, heating, removal) were sometimes needed before transferring the MoO₃ to the grating successfully. As a result, some portions of the grating were repeatedly contacted by the stamp and became contaminated. Such contaminated portions were later covered with the transferred flake.

4.3 Photothermal induced resonance measurements

4.3.1 Phonon polariton imaging and nanoscale point spectroscopy: All PTIR measurements in this work were made by using a resonance enhanced excitation scheme [75] with a gold-coated Si probe (nominal spring constant 0.07–0.4 N/m and first resonance frequency in air of 13 kHz ± 4 kHz) operated in contact mode. A quantum cascade laser (QCL) array with a tunable pulse repetition rate (1–2000 kHz) and wavelength (910–1905 cm⁻¹) was used to illuminate a region of the sample (diameter =50 μm) around the probe tip. Laser light (p-polarized) was obliquely incident upon flakes of MoO₃ such that multiple edges were illuminated at once. A phase-locked loop with 50–100 kHz bandwidth was used to maintain the resonant excitation condition by adjusting the laser pulse repetition rate to match one of the contact-resonance modes of the cantilever (=400 kHz), leading to a Q/2π amplification of the PTIR signal, where Q is the quality factor of the cantilever mode [75]. Absorption maps were measured by scanning the probe while illuminating the sample at a constant wavelength. Alternatively, by maintaining the probe at a fixed location and varying the wavelength of the incident IR light, point spectra were obtained by computing the ratios of the measured PTIR response to the laser output intensity at each wavelength (background spectrum). Since the QCL array consists of four chips, spectral artifacts can be introduced at the transitions between these chips (1179, 1473, and 1689 cm⁻¹) where the laser output intensity is relatively low. To enable easier side-by-side comparison, spectra were normalized to have a common intensity at one of these artifacts (1179 cm⁻¹), plotted with a common scale, and vertically offset for clarity.

4.3.2 Image processing and analysis: Simultaneously acquired topography and PTIR absorption map pairs were analyzed with customized processing routines to obtain estimates of HPhP propagation characteristics. The positions of MoO₃ crystal edges were determined by applying a Canny edge detection algorithm to flattened (plane-subtracted) topographs, enabling image segmentation into regions inside and outside of the analyzed flakes. One-dimensional absorption profiles were obtained from the 2D maps by column-wise (i.e., along the direction of the crystal edges) averaging, with only those portions inside the flake boundaries considered in the subsequent processing steps. To reduce the influence of low spatial frequency variations (e.g., ‘pink noise’) on HPhP analysis, exponentially decaying lines of best fit and arithmetic means were subtracted from the averaged absorption profiles. Excited HPhP modes within MoO₃ crystals were identified by peaks in the discrete Fourier transforms of these corrected absorption profiles. The wavenumbers were estimated from cubic spline interpolations of the resulting power spectra. These wavenumbers, as well as other characteristics of the detected HPhP modes, were refined by fitting the model expressed by Equation (1) to filtered absorption profiles; see Supplementary material S7. Filter functions exponentially damped absorption signals with spatial frequencies below about 65 % of the first detected peak position and above angular wavenumbers of about 100 μm⁻¹, while uniformly passing signals between these bounds. Group velocities were estimated by computing the numerical derivative of the HPhP dispersion relationship (e.g., Figure 2d) by using the symmetric finite difference method. Reported uncertainties for all quantities represent one standard deviation in the mean value. In the cases of quantities derived from least-squares fits, these values are from the propagated uncertainties obtained from the covariance matrices. The optimized fitting parameters were determined independently for each PTIR image. Therefore, the reported error bars only estimate fitting uncertainties of a single image (single IR wavelength) and do not account for image-to-image variability.

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